



APPLICANT'S ART CITATION (Use several sheets if necessary)	Application 10/009,249	OFGS File No. P/25-271
	Applicant Donald Dominic ARNONE et al.	
	Filing Date July 2, 2002	Group Art Unit 2881

## U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
	US-5,789,750	8/1998	Nuss			
	US-5,710,430	1/1998	Nuss			
	US-5,623,145	4/1997	Nuss			
	US-5,89,125	4/1999	Brener et al.			
	US-					
	US-					
	US-					

## FOREIGN PATENT DOCUMENTS

	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
	2 347 835	9/2000	Great Britain				
	2 075 668	11/1981	Great Britain				
	0 864 857 A1	9/1998	Europe				
	0 828 162 A2	3/1998	Europe				
	0 828 143 A2	3/1998	Europe				
	WO 88/01485	3/1988	PCT				

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	D.M. Mittleman et al: "T-ray Imaging" IEEE Journal of Selected topics in Quantum Electronics, vol. 2, no. 3, September 1996 (1996-09)
	S. Hunsche et al.: "THz Near-Field Imaging" Optics Communications 150 (1998) 22-26

Examiner	Date Considered 7-15-04
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.	